

## EDT2 IGBT and emitter controlled diode in TO247PLUS package

### Features

- $V_{CE} = 750\text{ V}$
- $I_C = 200\text{ A}$
- Best-in-class highest power density,  $I_C = 200\text{ A}$
- 750 V collector-emitter blocking voltage capability
- Suitable for 470 V  $V_{DC}$  systems and increase overvoltage margin for 400 V  $V_{DC}$  systems
- Very low  $V_{CE(sat)}$ , 1.30 V at  $I_{Cnom} = 200\text{ A}$ , 25°C
- Short circuit robust  $t_{sc} = 5\text{ }\mu\text{s}$  at  $V_{CE} = 470\text{ V}$ ,  $V_{GE} = 15\text{ V}$
- Self limiting current under short circuit condition
- Positive thermal coefficient and very tight parameter distribution for easy paralleling
- A Reduced number of parallel devices is required due to  $I_{nom} = 200\text{ A}$
- Excellent current sharing in parallel operation
- Smooth switching characteristics, low EMI signature
- Low gate charge  $Q_G$
- Simple gate drive design
- Co-packed with fast soft recovery emitter controlled 3 diode
- TO247PLUS package with high creepage distance
- High reliability

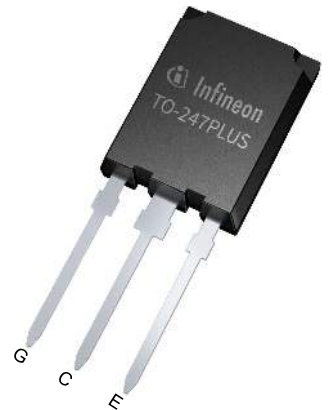
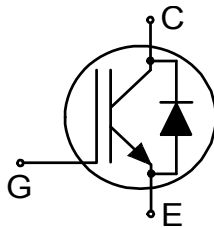
### Potential applications

- xEV Inverter
- DC-link discharge switch
- Automotive aux-drives

### Product validation

- Qualified for automotive applications
- Qualified according to AEC-Q101

### Description



Type	Package	Marking
AIKQ200N75CP2	PG-TO247PLUS-3	AKQ20FCP

## Table of contents

	<b>Description</b> .....	1
	<b>Features</b> .....	1
	<b>Potential applications</b> .....	1
	<b>Product validation</b> .....	1
	<b>Table of contents</b> .....	2
<b>1</b>	<b>Package</b> .....	3
<b>2</b>	<b>IGBT</b> .....	3
<b>3</b>	<b>Diode</b> .....	5
<b>4</b>	<b>Characteristics diagrams</b> .....	7
<b>5</b>	<b>Package outlines</b> .....	14
	<b>Revision history</b> .....	15
	<b>Disclaimer</b> .....	16

## 1 Package

**Table 1** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Internal emitter inductance measured 5 mm (0.197 in) from case	$L_E$			13.0		nH
Storage temperature	$T_{stg}$		-55		150	°C
Soldering temperature		wave soldering 1.6 mm (0.063 in.) from case for 10 s			260	°C
Thermal resistance, junction-ambient	$R_{th(j-a)}$				40	K/W

## 2 IGBT

**Table 2** Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Collector-emitter voltage	$V_{CE}$		750	V
DC collector current, limited by $T_{vjmax}$	$I_C$	$T_c = 25\text{ °C}$	200	A
		$T_c = 100\text{ °C}$	200	
Pulsed collector current, $t_p$ limited by $T_{vjmax}$	$I_{Cpulse}$		600	A
Turn-off safe operating area		$V_{CE} \leq 750\text{ V}$ , $t_p = 1\text{ }\mu\text{s}$ , $T_{vj} \leq 175\text{ °C}$	600	A
Gate-emitter voltage	$V_{GE}$		$\pm 20$	V
Transient gate-emitter voltage	$V_{GE}$	$t_p < 0.1\text{ }\mu\text{s}$ , $D < 0.01$	$\pm 30$	V
Short-circuit withstand time	$t_{SC}$	$V_{CC} \leq 470\text{ V}$ , $V_{GE} = 15\text{ V}$ , Allowed number of short circuits $< 1000$ , Time between short circuits $\geq 1.0\text{ s}$ , $T_{vj} = 25\text{ °C}$	5	$\mu\text{s}$
Power dissipation	$P_{tot}$	$T_c = 25\text{ °C}$	1071	W
		$T_c = 100\text{ °C}$	535	

**Table 3** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Collector-emitter saturation voltage	$V_{CEsat}$	$I_C = 200\text{ A}$ , $V_{GE} = 15\text{ V}$	$T_{vj} = 25\text{ °C}$		1.3	1.5	V
			$T_{vj} = 175\text{ °C}$		1.6		
Gate-emitter threshold voltage	$V_{GEth}$	$I_C = 2.6\text{ mA}$ , $V_{CE} = V_{GE}$ , $T_{vj} = 25\text{ °C}$	5	5.8	6.5	V	

**(table continues...)**

**Table 3 (continued) Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Zero gate-voltage collector current	$I_{CES}$	$V_{CE} = 750 \text{ V}, V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		200	$\mu\text{A}$
			$T_{vj} = 175 \text{ }^\circ\text{C}$		6000	
Gate-emitter leakage current	$I_{GES}$	$V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}$			100	nA
Transconductance	$g_{fs}$	$I_C = 200 \text{ A}, V_{CE} = 20 \text{ V}$		140		S
Short-circuit collector current	$I_{SC}$	$V_{CC} \leq 470 \text{ V}, V_{GE} = 15 \text{ V}, t_{SC} \leq 5 \mu\text{s}$ , Allowed number of short circuits < 1000, Time between short circuits $\geq 1.0 \text{ s}$ , $T_{vj} = 25 \text{ }^\circ\text{C}$		1250		A
Input capacitance	$C_{ies}$	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 100 \text{ kHz}$		21250		pF
Output capacitance	$C_{oes}$	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 100 \text{ kHz}$		535		pF
Reverse transfer capacitance	$C_{res}$	$V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 100 \text{ kHz}$		93		pF
Gate charge	$Q_G$	$I_C = 200 \text{ A}, V_{GE} = 15 \text{ V}, V_{CC} = 600 \text{ V}, V_{CE} = 600 \text{ V}$		1256		nC
Turn-on delay time	$t_{don}$	$V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega, R_{Goff} = 5 \Omega, L_\sigma = 50 \text{ nH}, C_\sigma = 30 \text{ pF}$	$T_{vj} = 25 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		89	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		85	
Rise time (inductive load)	$t_r$	$V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega, R_{Goff} = 5 \Omega, L_\sigma = 50 \text{ nH}, C_\sigma = 30 \text{ pF}$	$T_{vj} = 25 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		120	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		117	
Turn-off delay time	$t_{doff}$	$V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega, R_{Goff} = 5 \Omega, L_\sigma = 50 \text{ nH}, C_\sigma = 30 \text{ pF}$	$T_{vj} = 25 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		266	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		284	
Fall time (inductive load)	$t_f$	$V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega, R_{Goff} = 5 \Omega, L_\sigma = 50 \text{ nH}, C_\sigma = 30 \text{ pF}$	$T_{vj} = 25 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		46	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		60	
Turn-on energy <sup>1)</sup>	$E_{on}$	$V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega, R_{Goff} = 5 \Omega, L_\sigma = 50 \text{ nH}, C_\sigma = 30 \text{ pF}$	$T_{vj} = 25 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		15.3	mJ
			$T_{vj} = 175 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		16.3	
Turn-off energy	$E_{off}$	$V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega, R_{Goff} = 5 \Omega, L_\sigma = 50 \text{ nH}, C_\sigma = 30 \text{ pF}$	$T_{vj} = 25 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		7	mJ
			$T_{vj} = 175 \text{ }^\circ\text{C}, I_C = 200 \text{ A}$		8.1	

(table continues...)

**Table 3 (continued) Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Total switching energy	$E_{ts}$	$V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega, R_{Goff} = 5 \Omega, L_{\sigma} = 50 \text{ nH}, C_{\sigma} = 30 \text{ pF}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}, I_C = 200 \text{ A}$		22.3		mJ
			$T_{vj} = 175 \text{ }^{\circ}\text{C}, I_C = 200 \text{ A}$		24.4		
IGBT thermal resistance, junction to case <sup>2)</sup>	$R_{thjc}$			0.1	0.14	K/W	
Operating junction temperature	$T_{vj}$		-40		175	$^{\circ}\text{C}$	

1) Includes reverse recovery losses

2) Not subject to production test - specified by simulation

### 3 Diode

**Table 4 Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit	
Diode forward current, limited by $T_{vjmax}$	$I_F$		$T_c = 25 \text{ }^{\circ}\text{C}$	200	A
			$T_c = 100 \text{ }^{\circ}\text{C}$	200	
Diode pulsed current, limited by $T_{vjmax}$	$I_{Fpulse}$		600	A	
Power dissipation	$P_{tot}$		$T_c = 25 \text{ }^{\circ}\text{C}$	576	W
			$T_c = 100 \text{ }^{\circ}\text{C}$	288	

**Table 5 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Diode forward voltage	$V_F$	$I_F = 200 \text{ A}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$		1.8	1.95	V
			$T_{vj} = 175 \text{ }^{\circ}\text{C}$		1.9		
Diode reverse recovery charge	$Q_{rr}$	$V_R < 470 \text{ V}, R_{Gon} = 4.8 \Omega$	$T_{vj} = 25 \text{ }^{\circ}\text{C}, I_F = 200 \text{ A}, -di_F/dt = 1060 \text{ A}/\mu\text{s}$		4.7		$\mu\text{C}$
			$T_{vj} = 175 \text{ }^{\circ}\text{C}, I_F = 200 \text{ A}, -di_F/dt = 1110 \text{ A}/\mu\text{s}$		7.5		

(table continues...)

**Table 5 (continued) Characteristic values**

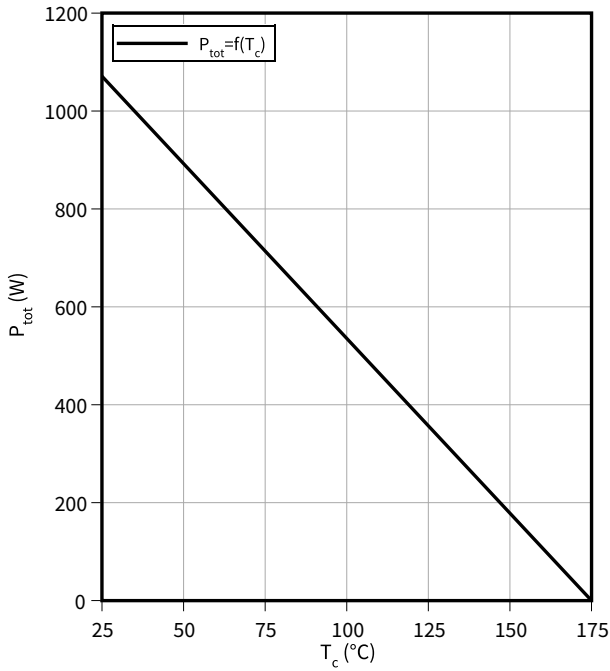
Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Diode peak reverse recovery current	$I_{rrm}$	$V_R < 470 \text{ V}$ , $R_{Gon} = 4.8 \text{ } \Omega$	$T_{vj} = 25 \text{ } ^\circ\text{C}$ , $I_F = 200 \text{ A}$ , $-di_F/dt = 1060 \text{ A}/\mu\text{s}$		41		A
			$T_{vj} = 175 \text{ } ^\circ\text{C}$ , $I_F = 200 \text{ A}$ , $-di_F/dt = 1110 \text{ A}/\mu\text{s}$		56		
Reverse recovery energy	$E_{rec}$	$V_R < 470 \text{ V}$ , $V_{GE} = -8/15 \text{ V}$ , $R_{Gon} = 4.8 \text{ } \Omega$ , $L_\sigma = 50 \text{ nH}$ , $C_\sigma = 30 \text{ pF}$	$T_{vj} = 25 \text{ } ^\circ\text{C}$ , $-di_F/dt = 1060 \text{ A}/\mu\text{s}$		1.3		mJ
			$T_{vj} = 175 \text{ } ^\circ\text{C}$ , $-di_F/dt = 1110 \text{ A}/\mu\text{s}$		2.2		
Diode thermal resistance, junction to case <sup>1)</sup>	$R_{thjc}$				0.2	0.26	K/W
Operating junction temperature	$T_{vj}$			-40		175	$^\circ\text{C}$

<sup>1)</sup> Not subject to test

## 4 Characteristics diagrams

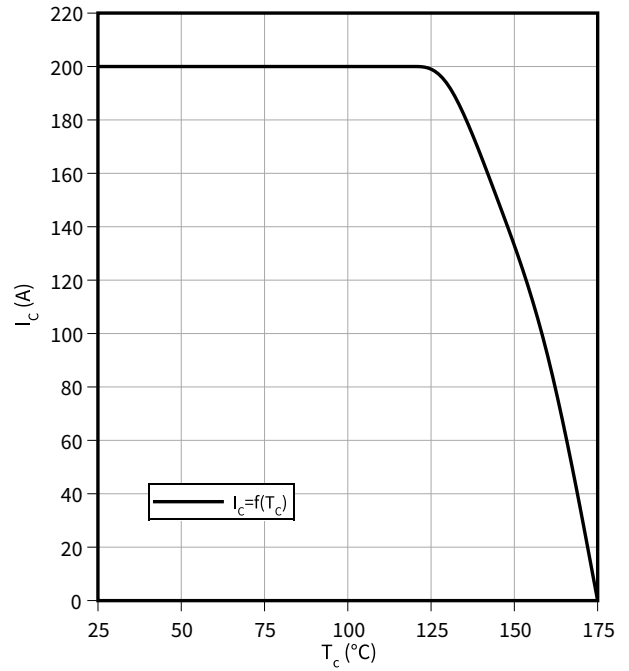
**Power dissipation as a function of case temperature, IGBT**

$P_{tot} = f(T_c)$   
 $T_{vj} \leq 175\text{ °C}$



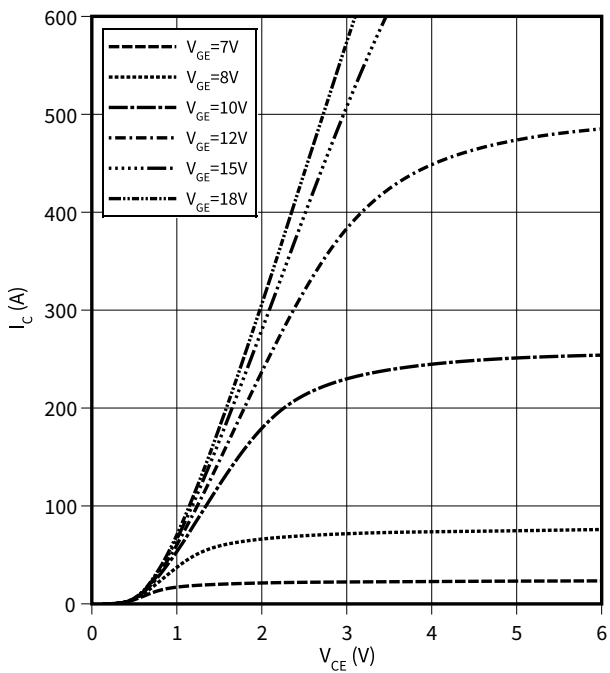
**Collector current as a function of case temperature, IGBT**

$I_C = f(T_c)$   
 $T_{vj} \leq 175\text{ °C}, V_{GE} = 15\text{ V}$



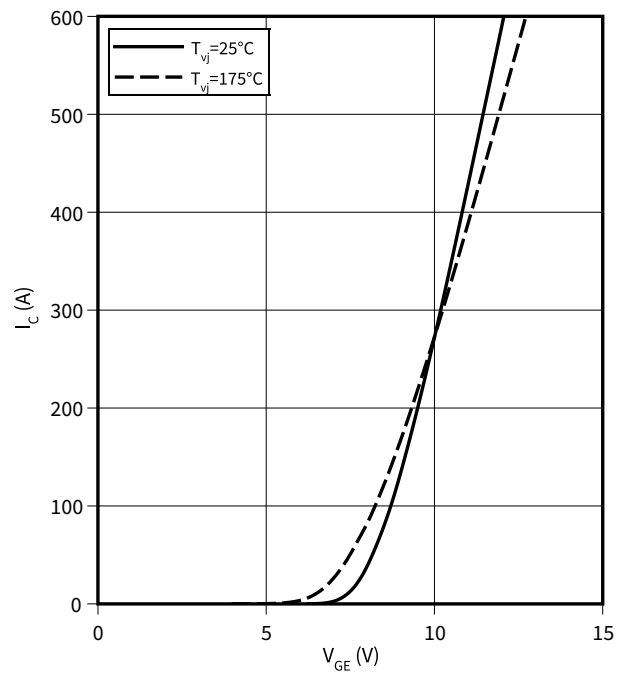
**Typical output characteristic, IGBT**

$I_C = f(V_{CE})$   
 $T_{vj} = 175\text{ °C}$



**Typical transfer characteristic, IGBT**

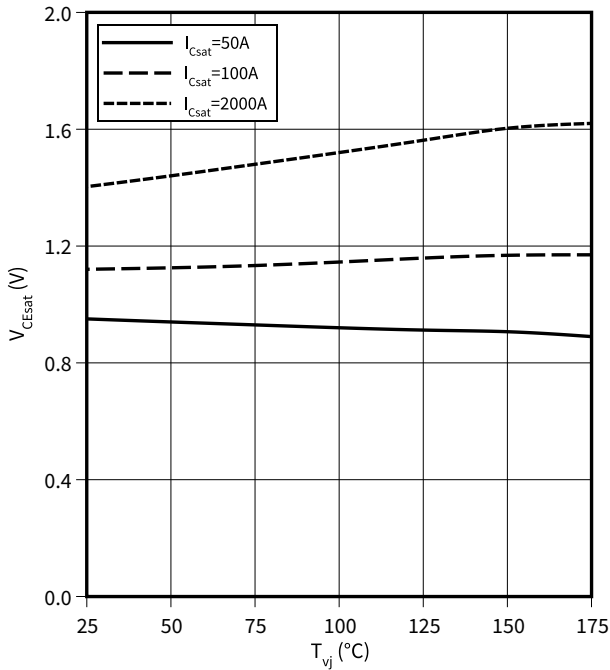
$I_C = f(V_{GE})$   
 $V_{CE} = 20\text{ V}$



4 Characteristics diagrams

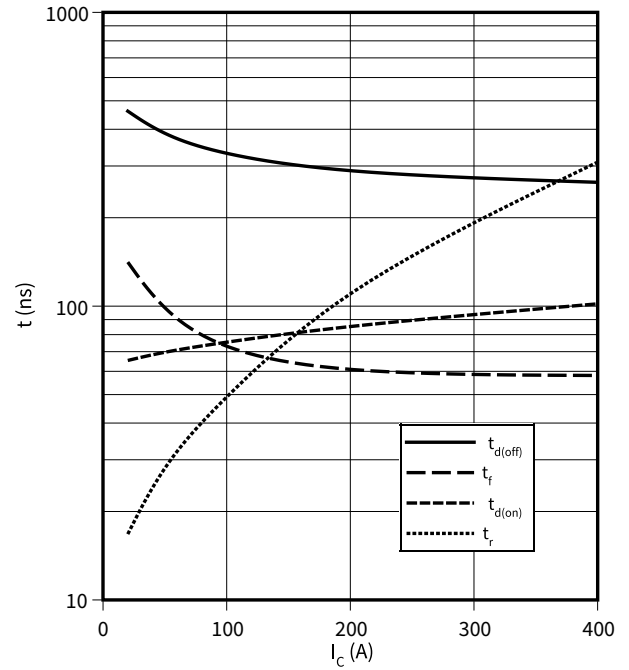
**Typical collector-emitter saturation voltage as a function of junction temperature, IGBT**

$V_{CEsat} = f(T_{vj})$   
 $V_{GE} = 15 \text{ V}$



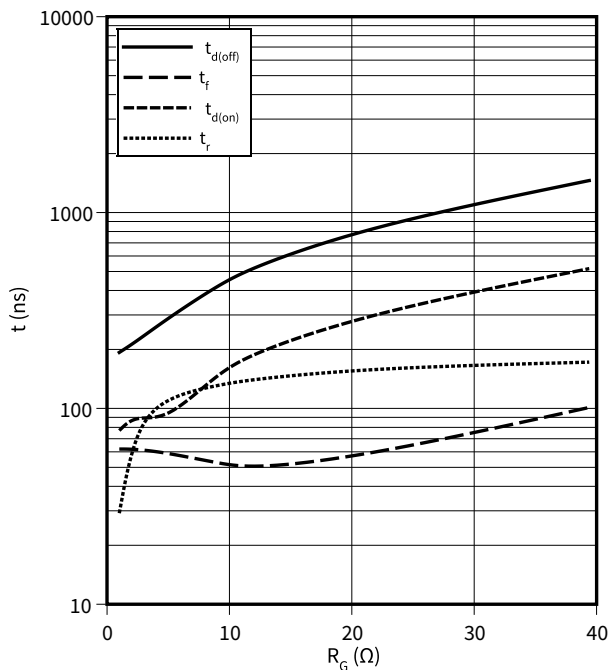
**Typical switching times as a function of collector current, IGBT**

$t = f(I_C)$   
 $R_{Goff} = 5 \Omega, V_{CE} = 25 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega$



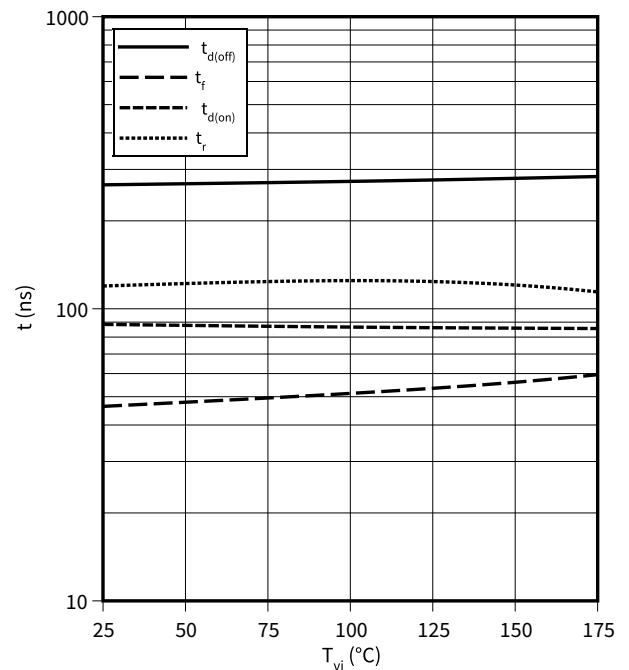
**Typical switching times as a function of gate resistor, IGBT**

$t = f(R_G)$   
 $I_C = 200 \text{ A}, V_{CE} = 470 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = -8/15 \text{ V}$



**Typical switching times as a function of junction temperature, IGBT**

$t = f(T_{vj})$   
 $I_C = 200 \text{ A}, R_{Goff} = 5.0 \Omega, V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega$

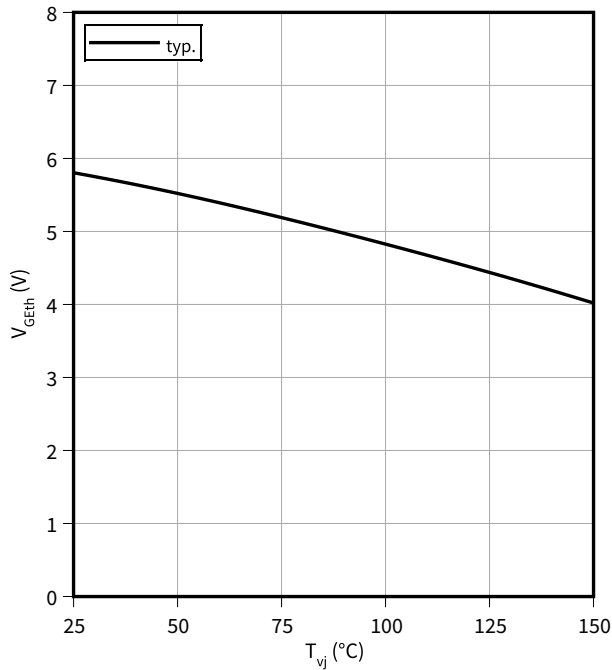




4 Characteristics diagrams

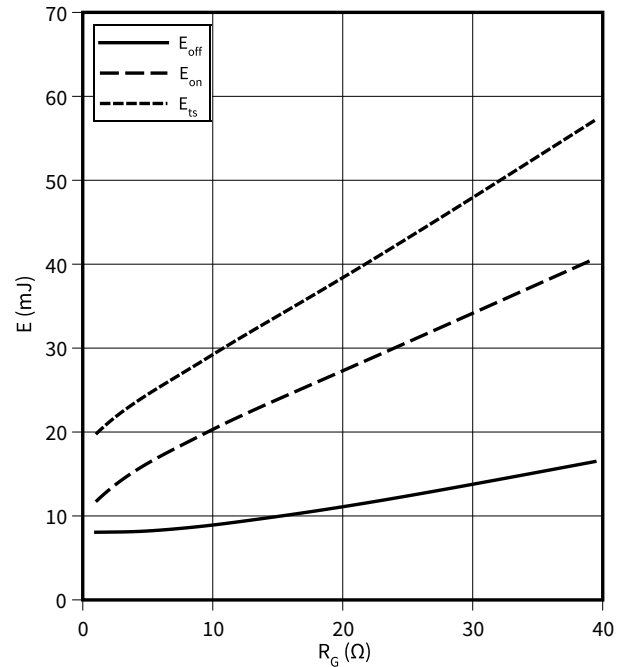
**Typical Gate-emitter threshold voltage as a function of junction temperature, IGBT**

$V_{GEth} = f(T_{vj})$   
 $I_C = 2.60 \text{ mA}$



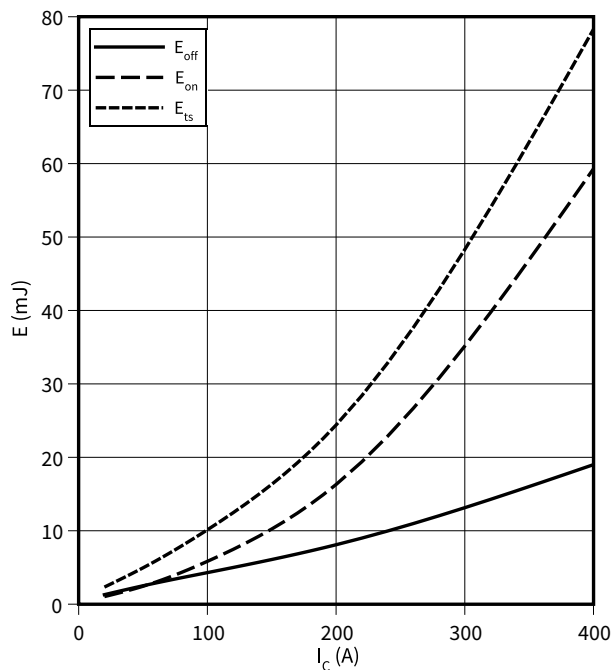
**Typical switching energy losses as a function of gate resistor, IGBT**

$E = f(R_G)$   
 $I_C = 200 \text{ A}, V_{CE} = 25 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = -8/15 \text{ V}$



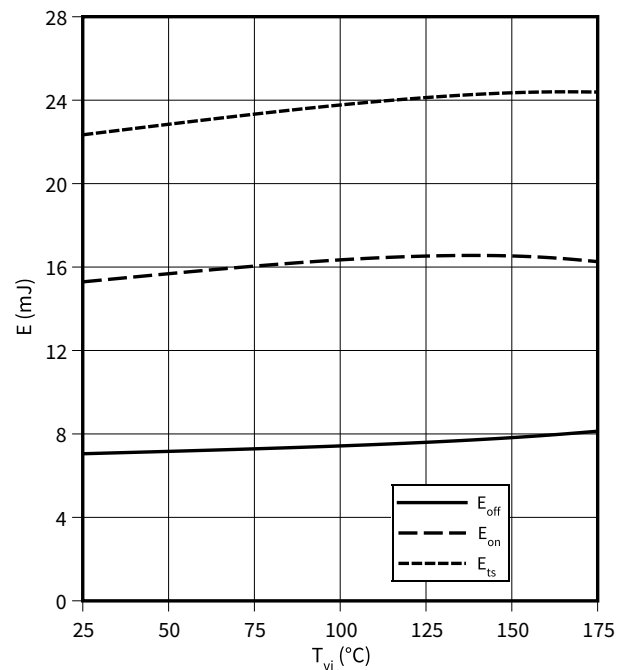
**Typical switching energy losses as a function of collector current, IGBT**

$E = f(I_C)$   
 $R_{Goff} = 5 \Omega, V_{CE} = 25 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega$



**Typical switching energy losses as a function of junction temperature, IGBT**

$E = f(T_{vj})$   
 $I_C = 200 \text{ A}, R_{Goff} = 5.0 \Omega, V_{CE} = 470 \text{ V}, V_{GE} = -8/15 \text{ V}, R_{Gon} = 5 \Omega$

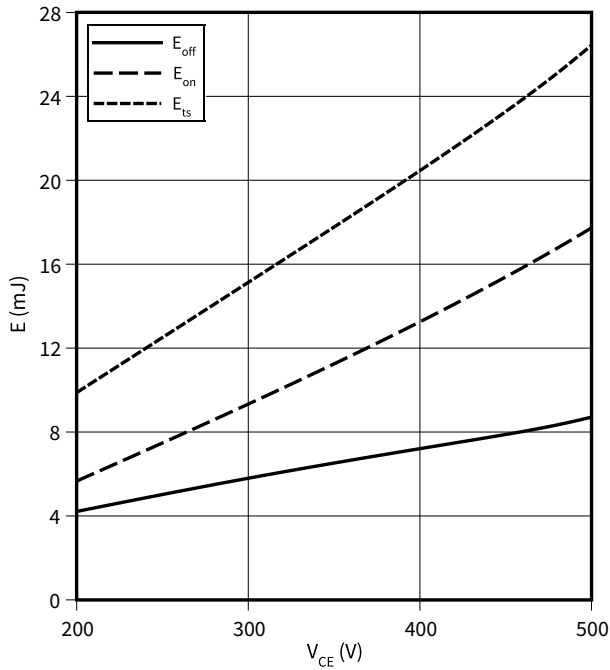


4 Characteristics diagrams

**Typical switching energy losses as a function of collector-emitter voltage, IGBT**

$E = f(V_{CE})$

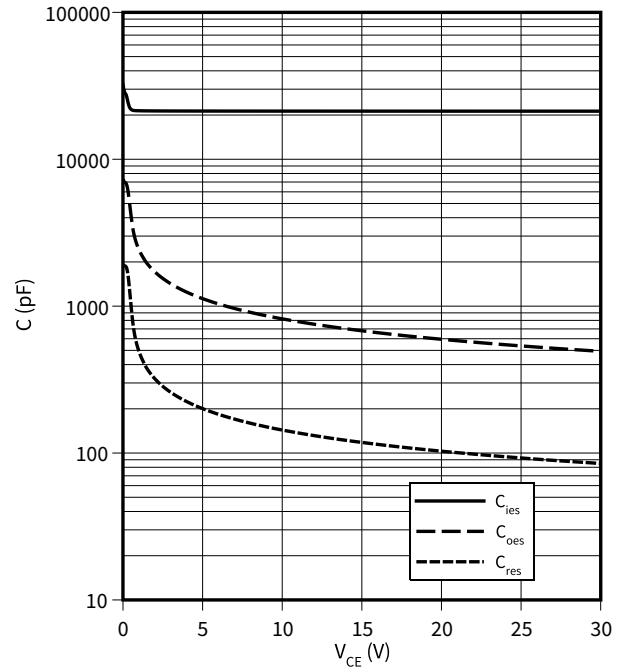
$I_C = 200\text{ A}$ ,  $R_{Goff} = 5\ \Omega$ ,  $T_{vj} \leq 175\text{ }^\circ\text{C}$ ,  $V_{GE} = -8/15\text{ V}$ ,  $R_{Gon} = 5\ \Omega$



**Typical capacitance as a function of collector-emitter voltage, IGBT**

$C = f(V_{CE})$

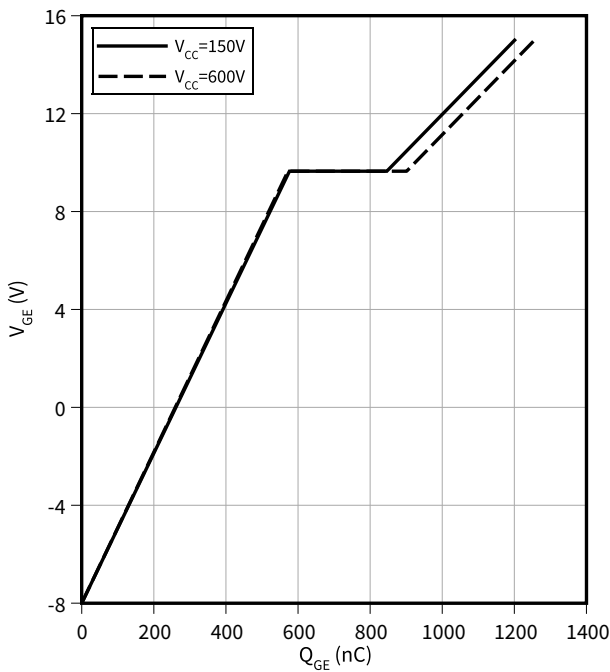
$f = 100\text{ kHz}$ ,  $V_{GE} = 0\text{ V}$



**Typical gate charge, IGBT**

$V_{GE} = f(Q_{GE})$

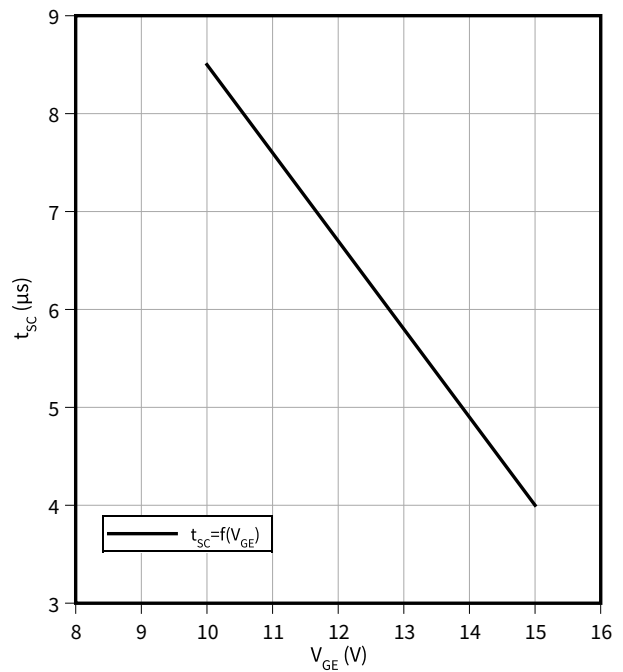
$I_C = 200\text{ A}$



**Typical Short circuit withstand time as a function of gate-emitter voltage, IGBT**

$t_{SC} = f(V_{GE})$

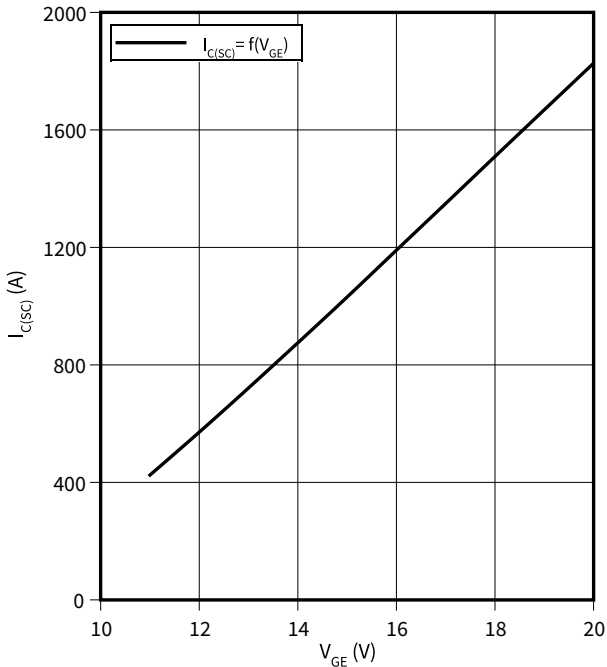
$T_{vj} \leq 175\text{ }^\circ\text{C}$ ,  $V_{CC} \leq 470\text{ V}$



4 Characteristics diagrams

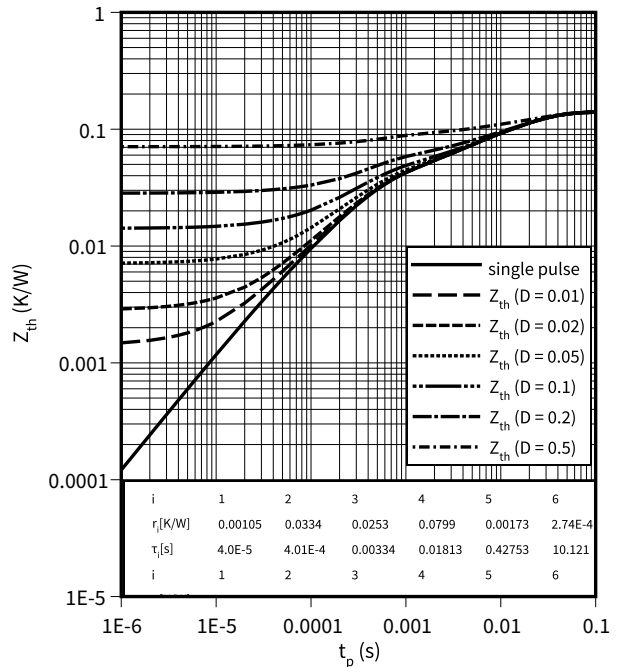
**Typical short circuit collector current as a function of gate-emitter voltage, IGBT**

$I_{C(SC)} = f(V_{GE})$   
 $T_{vj} \leq 175\text{ }^\circ\text{C}, V_{CC} \leq 470\text{ V}$



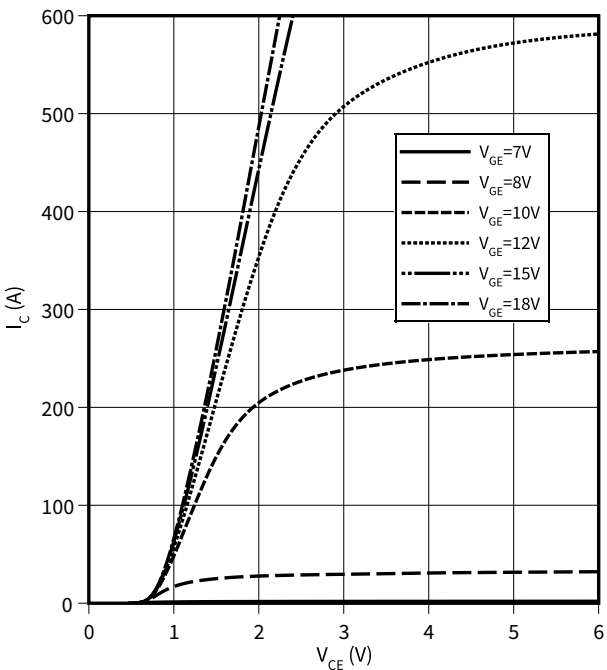
**IGBT transient thermal impedance as a function of pulse width, IGBT**

$Z_{th} = f(t_p)$   
 $D = t_p/T$



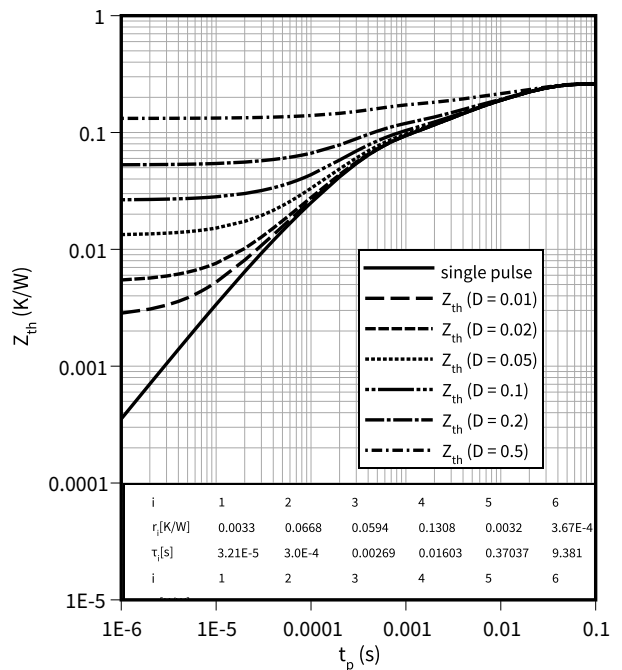
**Typical output characteristic, IGBT**

$I_C = f(V_{CE})$   
 $T_{vj} = 25\text{ }^\circ\text{C}$



**Diode transient thermal impedance as a function of pulse width, Diode**

$Z_{th} = f(t_p)$   
 $D = t_p/T$

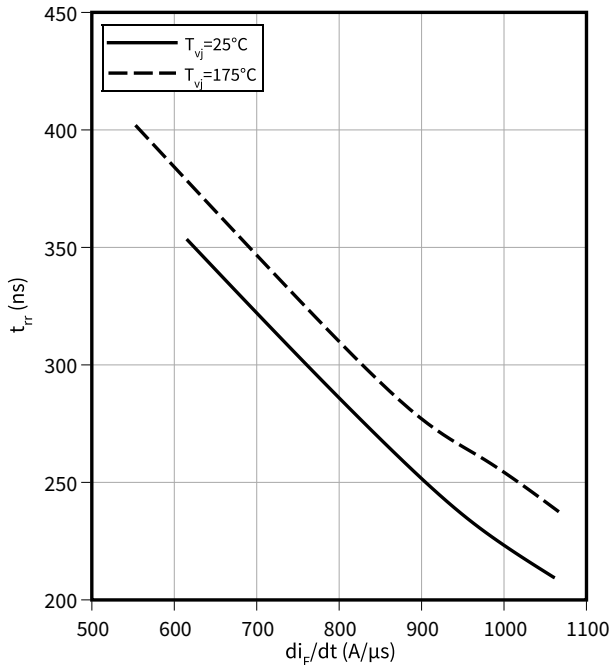


4 Characteristics diagrams

**Typical reverse recovery time as a function of diode current slope, Diode**

$t_{rr} = f(di_F/dt)$

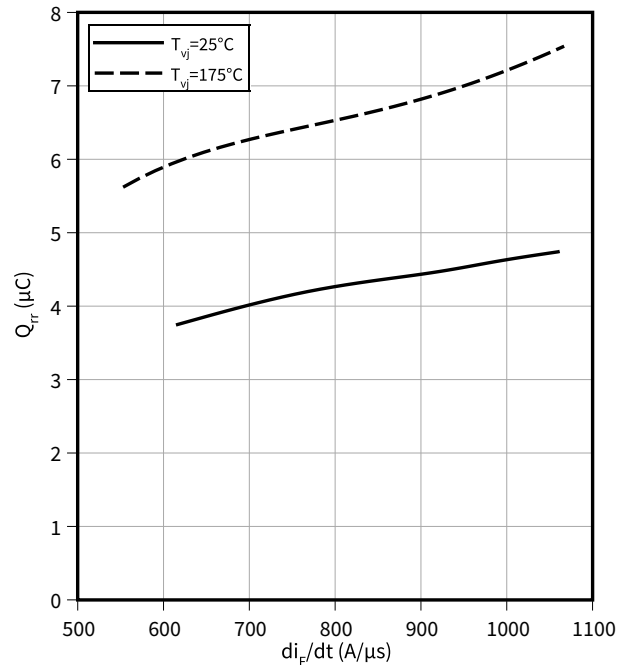
$V_R < 470 \text{ V}, I_F = 200 \text{ A}$



**Typical reverse recovery charge as a function of diode current slope, Diode**

$Q_{rr} = f(di_F/dt)$

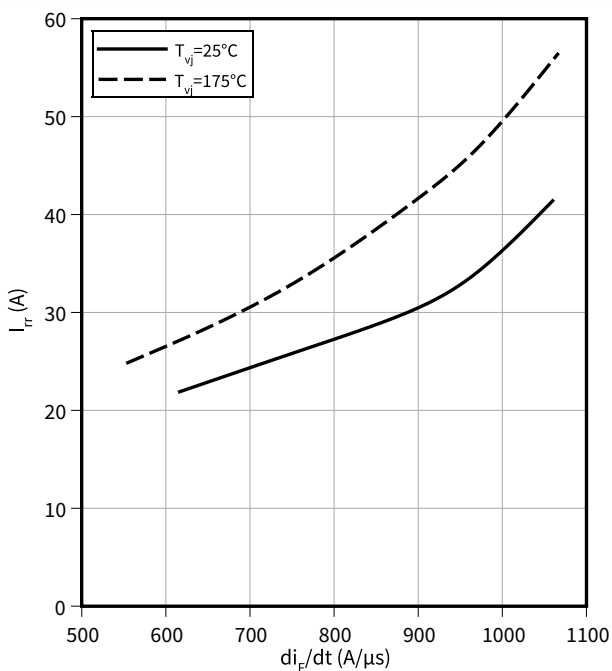
$V_R < 470 \text{ V}, I_F = 200 \text{ A}$



**Typical reverse recovery current as a function of diode current slope, Diode**

$I_{rr} = f(di_F/dt)$

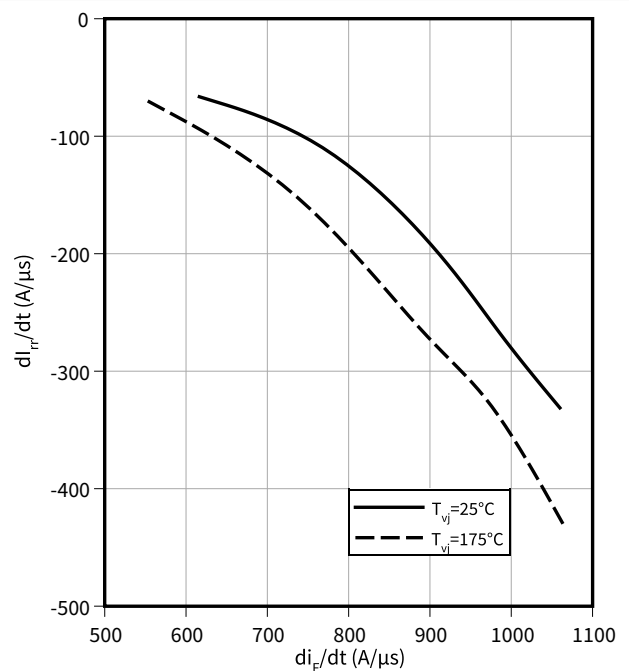
$V_R < 470 \text{ V}, I_F = 200 \text{ A}$



**Typical diode peak rate of fall of reverse recovery current as a function of diode current slope, Diode**

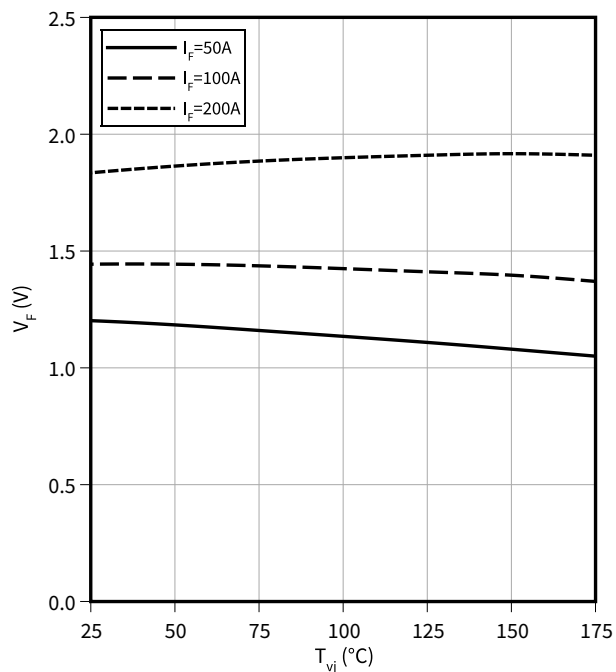
$dl_{rr}/dt = f(di_F/dt)$

$V_R < 470 \text{ V}, I_F = 200 \text{ A}$



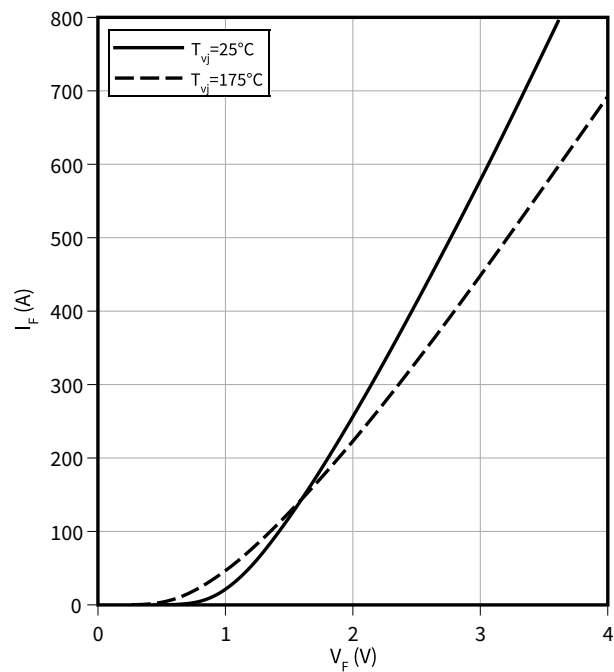
**Typical diode forward voltage as a function of junction temperature, Diode**

$$V_F = f(T_{vj})$$



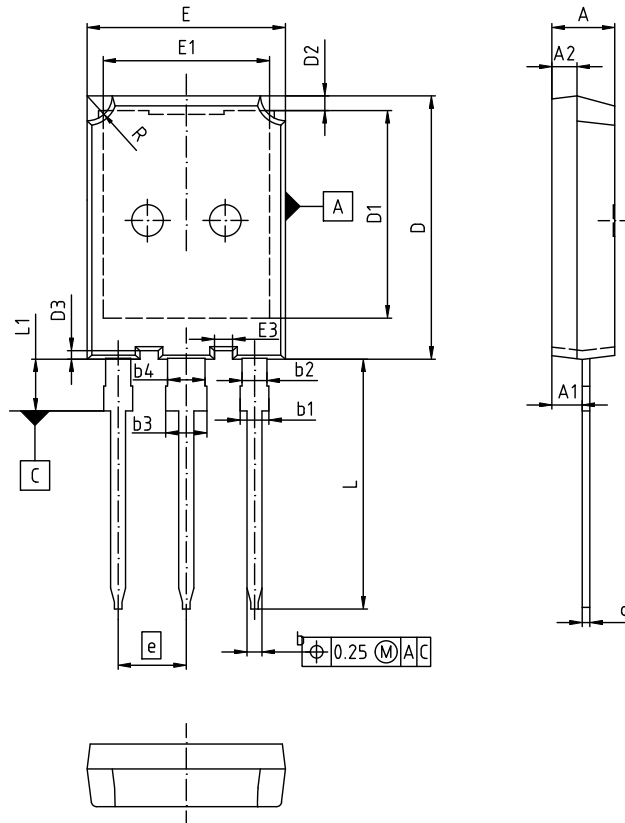
**Typical diode forward current as a function of forward voltage, Diode**

$$I_F = f(V_F)$$



5 Package outlines

Package Drawing PG-TO247PLUS-3



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.90	5.10	0.193	0.201
A1	2.31	2.51	0.091	0.099
A2	1.90	2.10	0.075	0.083
b	1.16	1.26	0.046	0.050
b1	1.96	2.25	0.077	0.089
b2	1.96	2.06	0.077	0.081
c	0.59	0.66	0.023	0.026
D	20.90	21.10	0.823	0.831
D1	16.25	16.85	0.640	0.663
D2	1.05	1.35	0.041	0.053
D3	0.58	0.78	0.023	0.031
E	15.70	15.90	0.618	0.626
E1	13.10	13.50	0.516	0.531
E3	1.35	1.55	0.053	0.061
e	5.44 (BSC)		0.214 (BSC)	
N	3		3	
L	19.80	20.10	0.780	0.791
L1	-	4.30	-	0.169
R	1.90	2.10	0.075	0.083

DOCUMENT NO.  
Z8B00174295

SCALE

EUROPEAN PROJECTION

ISSUE DATE  
13-08-2014

REVISION  
01

Figure 1

## Revision history

Document revision	Date of release	Description of changes
V0.1	2020-10-09	Target
V0.2	2020-11-02	Updated marking on page1
V0.1		Target
n/a	2020-11-30	Datasheet migrated to a new system with a new layout and new revision number schema: target or preliminary datasheet = 0.xy; final datasheet = 1.xy
1.00	2022-02-16	Final datasheet
1.10	2022-03-16	Updated Isc and Rthjc

## Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

**Edition 2022-03-16**

**Published by**

**Infineon Technologies AG**

**81726 Munich, Germany**

**© 2022 Infineon Technologies AG**

**All Rights Reserved.**

**Do you have a question about any aspect of this document?**

**Email: [erratum@infineon.com](mailto:erratum@infineon.com)**

**Document reference**

**IFX-AAL443-004**

## IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

## WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.